











TPD4E001-Q1

SLLSEGOD -MARCH 2013-REVISED AUGUST 2015

TPD4E001-Q1 4-Channel ESD Protection Array With 1.5-pF I/O Capacitance

Features

- AEC-Q100 Qualified With the Following Results:
 - Device Temperature Grade 1: –40°C to 125°C Ambient Operating Temperature Range
 - Device HBM ESD Classification Level 3B
 - HBM Level 15 kV
 - Device CDM ESD Classification Level C5
- IEC 61000-4-2 Level 4 ESD Protection
 - ±8-kV Contact Discharge
 - ±15-kV Air-Gap Discharge
- IEC 61000-4-5 Surge Protection
 - 5.5 A (8/20 µs)
- Low 1.5-pF Input Capacitance
- Low 10-nA Maximum Leakage Current
- 0.9-V to 5.5-V Supply Voltage Range

Applications

- **End Equipment**
 - Automotive Head Unit
 - **Automotive Rear Seat Entertainment**
 - Automotive Rear Camera Systems
- Interfaces
 - **USB 2.0**
 - Ethernet
 - **Precision Analog Interfaces**

3 Description

The TPD4E001-Q1 device is a low-capacitance TVS diode array designed for ESD protection in sensitive electronics connected to communication lines. Each channel consists of a pair of transient-voltagesuppression diodes that steer ESD pulses to V_{CC} or GND. The TPD4E001-Q1 protects against ESD events up to ±8-kV contact discharge and ±15-kV airgap discharge, as specified in IEC 61000-4-2 international standard. This device has a low capacitance of 1.5-pF per channel making it ideal for use in high-speed data interfaces. The low leakage current (10 nA maximum) ensures minimum power consumption for the system and high accuracy for analog interfaces.

Additionally, this device is ideal for protecting automotive head units, automotive rear seat entertainment, and automotive rear camera systems that use USB 2.0, Ethernet, or precision analog interfaces.

Device Information(1)

PART NUMBER	PACKAGE	BODY SIZE (NOM)
TPD4E001-Q1	SOT-23 (6)	2.90 mm × 1.60 mm

(1) For all available packages, see the orderable addendum at the end of the datasheet.

Typical Schematic

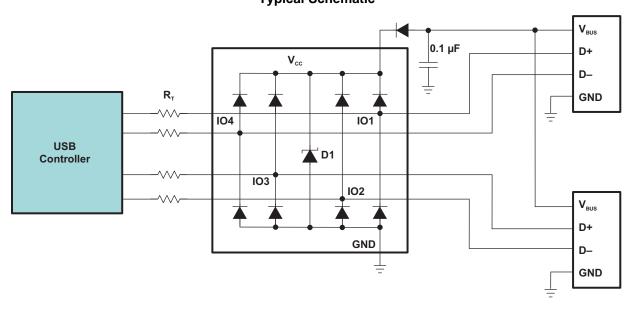




Table of Contents

1	Features 1		7.3 Feature Description	6
2	Applications 1		7.4 Device Functional Modes	7
3	Description 1	8	Application and Implementation	7
4	Revision History2		8.1 Application Information	7
5	Pin Configuration and Functions		8.2 Typical Application	7
6	Specifications	9	Power Supply Recommendations	9
•	6.1 Absolute Maximum Ratings	10	Layout	10
	6.2 ESD Ratings: AEC Q100		10.1 Layout Guidelines	10
	6.3 ESD Ratings: IEC 61000-4-2		10.2 Layout Example	10
	6.4 Recommended Operating Conditions	11	Device and Documentation Support	
	6.5 Thermal Information		11.1 Community Resources	11
	6.6 Electrical Characteristics		11.2 Trademarks	11
	6.7 Typical Characteristics5		11.3 Electrostatic Discharge Caution	11
7	Detailed Description 6		11.4 Glossary	11
•	7.1 Overview 6	12	Mechanical, Packaging, and Orderable	
	7.2 Functional Block Diagram 6		Information	11

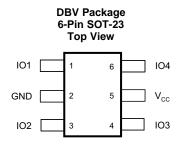
4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

CI	hanges from Revision C (June 2013) to Revision D	Page
•	Added Pin Configuration and Functions section, ESD Ratings table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section	
CI	hanges from Revision B (February 2012) to Revision C	Page
•	Changed maximum I _{CC} supply current in Electrical Characteristics	4
CI	hanges from Revision A (April 2013) to Revision B	Page
•	Revised text in DESCRIPTION section	1
•	Revised Figure 2 graph	4
_	Poviged APPLICATION INFORMATION cohemotic	7



5 Pin Configuration and Functions



Pin Functions

PIN		TYPE	DESCRIPTION				
NAME	NO.	ITPE	DESCRIPTION				
GND	2	GND	Ground				
IO1	1						
IO2	3	1/0	FOD and to to to to to a col				
IO3	4	I/O	ESD-protected channel				
104	6						
V _{CC}	5	I	Power-supply input. Bypass V _{CC} to GND with a 0.1-µF ceramic capacitor.				

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)

		MIN	MAX	UNIT
V_{CC}	Supply voltage	-0.3	7	V
V_{IO}	I/O voltage tolerance	-0.3	$V_{CC} + 0.3$	V
I _{PP}	Peak pulse current (Tp = 8/20 µs) ⁽²⁾		5.5	Α
P_{PP}	Peak pulse power (Tp = $8/20 \mu s$) ⁽²⁾		100	W
T _A	Free air operating temperature	-40	125	°C
T_{J}	Junction temperature		150	°C
T _{stg}	Storage temperature	-65	150	°C

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings: AEC Q100

			VALUE	UNIT
V	Electrostatic	Human-body model (HBM), per AEC Q100-002 ⁽¹⁾	±15000	V
V(ESD)	discharge	Charged-device model (CDM), per AEC Q100-011	±750	V

⁽¹⁾ AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

6.3 ESD Ratings: IEC 61000-4-2

			VALUE	UNIT
V _(ESD)	Clastrostatia diseberge	IEC 61000-4-2 contact discharge	±8000	V
	Electrostatic discharge	IEC 61000-4-2 air-gap discharge	±15000	V

⁽²⁾ Non-repetitive current pulse 8/20 µs exponentially decaying waveform according to IEC 61000-4-5.



6.4 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM MAX	UNIT
T _A	Free air operating temperature	-40	125	°C
V _{CC} pin	Operating voltage	0.9	5.5	V
IO1, IO2, IO3, IO4 pins	Operating voltage	0	V_{CC}	V

6.5 Thermal Information

		TPD4E001-Q1	
	THERMAL METRIC ⁽¹⁾	DBV (SOT-23)	UNIT
		6 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	202.1	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	146.2	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	47.1	°C/W
ΨЈТ	Junction-to-top characterization parameter	37.6	°C/W
ΨЈВ	Junction-to-board characterization parameter	46.7	°C/W

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

6.6 Electrical Characteristics

 V_{CC} = 5 V ± 10%, over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITION	vs	MIN	TYP ⁽¹⁾	MAX	UNIT
I _{CC}	Supply current			1	200	nA	
V_{F}	Diode forward voltage	I _F = 10 mA	0.65		0.95	V	
V_{BR}	Breakdown voltage	I _{BR} = 10 mA	11			V	
V _{CLAMP}	Clamping voltage	Surge strike $^{(2)}$ on IO pin, GND pin grounded, $V_{CC} = 5.5 \text{ V}$, $I_{PP} = 5.5 \text{ A}$	Positive transients		16		V
V_{RWM}	Reverse standoff voltage	IO pin to GND pin				5.5	V
I _{IO}	Channel leakage current	V_{IO} = GND to V_{CC}			±10	nA	
C _{IO}	Channel input capacitance	$V_{CC} = 5 \text{ V}$, bias of $V_{CC}/2$, f = 10 MHz			1.5		pF

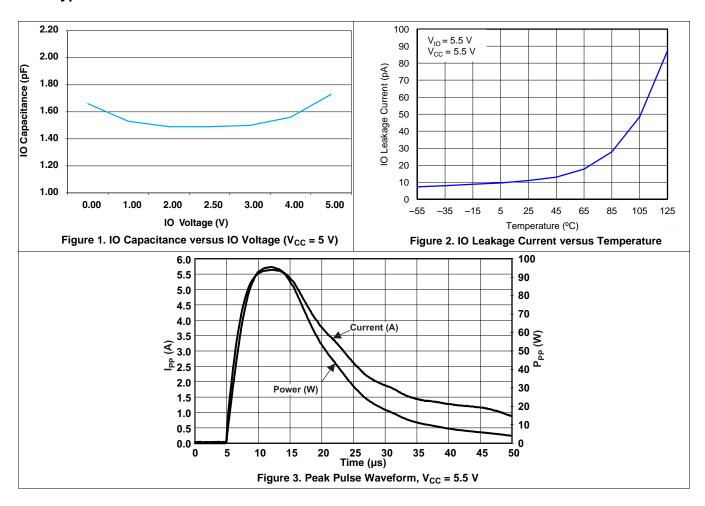
Submit Documentation Feedback

Copyright © 2013-2015, Texas Instruments Incorporated

⁽¹⁾ Typical values are at V_{CC} = 5 V and T_A = 25°C. (2) Non-repetitive current pulse 8/20 μ s exponentially decaying waveform according to IEC 61000-4-5.



6.7 Typical Characteristics



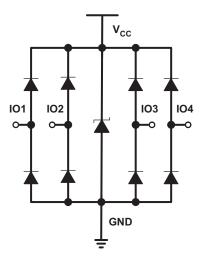


7 Detailed Description

7.1 Overview

The TPD4E001-Q1 device is a low-capacitance, TVS diode array designed for ESD protection in sensitive electronics connected to communication lines. Each channel consists of a pair of transient voltage suppression diodes that steer ESD pulses to V_{CC} or GND. The TPD4E001-Q1 device protects against ESD events up to ± 8 -kV contact discharge and ± 15 -kV air-gap discharge, as specified in IEC 61000-4-2 international standard. This device has a low capacitance of 1.5-pF per channel making it ideal for use in high-speed data interfaces. The low-leakage current (10 nA max) ensures minimum power consumption for the system and high accuracy for analog interfaces.

7.2 Functional Block Diagram



7.3 Feature Description

7.3.1 AEC-Q100 Qualified

This device is qualified according to the AEC-Q100 standard. The device temperature rating is Grade 1 (-40°C to 125°C). The HBM Classification Level passed is 3B (> 8 kV). The CDM Classification Level passed is C5 (all pins 750 V to <1000 V).

7.3.2 IEC 61000-4-2 Level 4 ESD Protection

The device is specified at ±8-kV contact discharge and ±15-kV air gap discharge.

7.3.3 IEC 61000-4-5 Surge Protection

This device is rated to pass at least 5.5-A of peak pulse current according to the IEC 61000-4-5 (8/20-µs pulse) standard.

7.3.4 Low 1.5-pF Input Capacitance

This device has a typical capacitance of 1.5-pF on each of the four IO pins. This allows for high speed signals on the IO pins in excess of 1 Gbps.

7.3.5 Low 10-nA (Max) Leakage Current

This device is rated to have a maximum leakage current of 10-nA on each of the four IO pins.

7.3.6 0.9-V to 5.5-V Supply Voltage Range

This device is specified to operate with a supply voltage (on V_{CC}) between 0.9-V and 5.5-V to ensure sufficient signal integrity.



7.4 Device Functional Modes

The TPD4E001-Q1 device is a passive integrated circuit that triggers when voltages are above V_{BR} or below the lower diodes V_F (-0.6 V). During ESD events, voltages as high as ±8 kV (contact) can be directed to ground via the internal diode network. Once the voltages on the protected line fall below the trigger levels of TPD4E001-Q1 (usually within 10's of nano-seconds) the device reverts back to its high-impedance state.

8 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

The TPD4E001-Q1 device is a TVS diode array which is typically used to provide a path to ground for dissipating ESD events on high-speed signal lines between a human interface connector and a system. As the current from ESD passes through the TVS, only a small voltage drop is present across the diode. This is the voltage presented to the protected IC. The triggered TVS holds this voltage, V_{CLAMP}, to a safe level for the protected IC.

8.2 Typical Application

For this design example, one TPD4E001-Q1 device is being used in a dual USB 2.0 application. This will provide a complete port protection scheme.

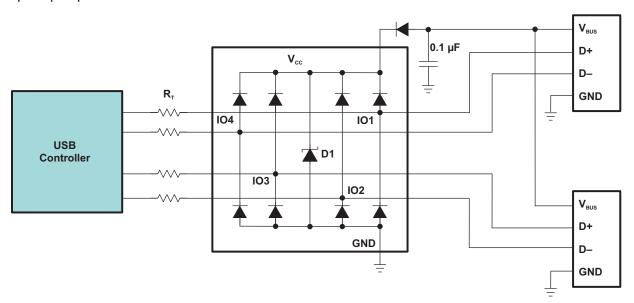


Figure 4. Typical Application Schematic

Submit Documentation Feedback



Typical Application (continued)

8.2.1 Design Requirements

For this design example, a single TPD4E001-Q1 device is used to protect all the pins on two USB2.0 connectors. Given the USB application, known parameters are listed in the Table 1 table.

Table 1. Design Parameters

DESIGN PARAMETER	VALUE
Signal range on IO1, IO2, IO3, or IO4	0 V to 3.6 V
Voltage range on V _{CC}	0 V to 5.25 V
Operating Frequency on IO1, IO2, IO3, or IO4	240 MHz

8.2.2 Detailed Design Procedure

To begin the design process, some parameters must be decided upon; the designer needs to know the following:

- · Signal range on all protected lines
- · Operating frequency on all protected lines

8.2.2.1 Signal Range on IO1 Through IO4

The TPD4E001-Q1 device has 4 identical protection channels for signal lines. The symmetry of the device provides flexibility when selecting which of the 4 IO channels will protect which signal lines. Any IO will support a signal range of 0 to $(V_{CC} + 0.3)$ V. Therefore, this device will support the USB 2.0 signal swing assuming V_{CC} is set appropriately.

8.2.2.2 Voltage Range on V_{CC}

The V_{CC} pin can be connected in one of two ways:

- If the V_{CC} pin connects to the system power supply, the TPD4E001-Q1 device works as a transient suppressor for any signal swing above V_{CC} + V_F . TI recommends a 0.1- μF capacitor on the device V_{CC} pin for ESD bypass.
- If the V_{CC} pin does not connect to the system power supply, the TPD4E001-Q1 device can tolerate higher signal swing in the range up to 10 V. Note that TI still recommends a 0.1-μF capacitor at the V_{CC} pin for ESD bypass.

If this pin is connected to the USB 2.0 V_{BUS} supply or left floating, the allowable signal swing is enough for a USB 2.0 application.

8.2.2.3 Bandwidth on IO1 Through IO4

Each IO pin on the TPD4E001-Q1 device has a typical capacitance of 1.5 pF. This capacitance is low enough to easily support USB 2.0 data rates.



8.2.3 Application Curve

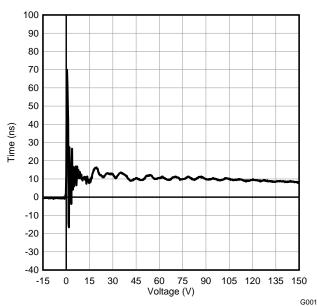


Figure 5. IEC 61000-4-2 Voltage Clamp Waveform +8kV Contact

9 Power Supply Recommendations

This device is a passive ESD protection device so there is no need to power it. Do not violate the maximum voltage specifications for each pin.

Copyright © 2013–2015, Texas Instruments Incorporated

Product Folder Links: *TPD4E001-Q1*



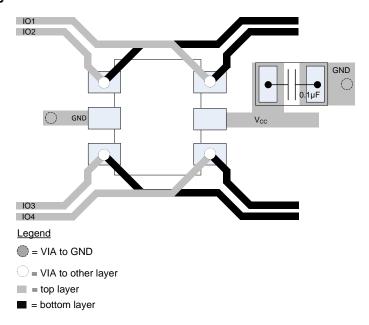
10 Layout

10.1 Layout Guidelines

When placed near the connector, the TPD4E001-Q1 device's ESD solution offers little or no signal distortion during normal operation due to low IO capacitance and ultra-low leakage-current specifications. The TPD4E001-Q1 device ensures that the core circuitry is protected and the system is functioning properly in the event of an ESD strike. For proper operation, observe the following layout and design guidelines:

- Place the TPD4E001-Q1 device solution close to the connector. This allows the device to take away the
 energy associated with ESD strike before it reaches the internal circuitry of the system board.
- Place a $0.1-\mu F$ capacitor very close to the V_{CC} pin. This limits any momentary voltage surge at the IO pin during the ESD strike event.
- Ensure that there is enough metallization for the V_{CC} and GND loop. During normal operation, the TPD4E001-Q1 device consumes nA leakage current. But during the ESD event, V_{CC} and GND may see 15 A to 30 A of current, depending on the ESD level. Sufficient current path enables safe discharge of all the energy associated with the ESD strike.
- · Leave the unused IO pins floating.
- One can connect the V_{CC} pin in two different ways:
 - a. If the V_{CC} pin connects to the system power supply, the TPD4E001-Q1 works as a transient suppressor for any signal swing above V_{CC} + V_F . TI recommends a 0.1- μ F capacitor on the device V_{CC} pin for ESD bypass.
 - b. If the V_{CC} pin does not connect to the system power supply, the TPD4E001-Q1 can tolerate higher signal swing in the range up to 10 V. Note that TI still recommends a 0.1-μF capacitor at the V_{CC} pin for ESD bypass.
- The optimum placement is as close to the connector as possible.
 - EMI during an ESD event can couple from the trace being struck to other nearby unprotected traces, resulting in early system failures.
 - The PCB designer needs to minimize the possibility of EMI coupling by keeping any unprotected traces away from the protected traces which are between the TVS and the connector.
- Route the protected traces as straight as possible.
- Eliminate any sharp corners on the protected traces between the TVS and the connector by using rounded corners with the largest radii possible.
 - Electric fields tend to build up on corners, increasing EMI coupling.

10.2 Layout Example





11 Device and Documentation Support

11.1 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

11.2 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

11.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

11.4 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGE OPTION ADDENDUM

25-Feb-2015

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
TPD4E001QDBVRQ1	ACTIVE	SOT-23	DBV	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	AAXQ	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.



PACKAGE OPTION ADDENDUM

25-Feb-2015

OTHER QUALIFIED VERSIONS OF TPD4E001-Q1:

www.ti.com

NOTE: Qualified Version Definitions:

• Catalog - TI's standard catalog product

PACKAGE MATERIALS INFORMATION

www.ti.com 24-Feb-2015

TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPD4E001QDBVRQ1	SOT-23	DBV	6	3000	178.0	9.0	3.23	3.17	1.37	4.0	8.0	Q3

PACKAGE MATERIALS INFORMATION

www.ti.com 24-Feb-2015



*All dimensions are nominal

Device		Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
	TPD4E001QDBVRQ1	SOT-23	DBV	6	3000	180.0	180.0	18.0	

DBV (R-PDSO-G6)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
- D. Leads 1,2,3 may be wider than leads 4,5,6 for package orientation.
- Falls within JEDEC MO-178 Variation AB, except minimum lead width.



DBV (R-PDSO-G6)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.



IMPORTANT NOTICE

Texas Instruments Incorporated (TI) reserves the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete.

TI's published terms of sale for semiconductor products (http://www.ti.com/sc/docs/stdterms.htm) apply to the sale of packaged integrated circuit products that TI has qualified and released to market. Additional terms may apply to the use or sale of other types of TI products and services.

Reproduction of significant portions of TI information in TI data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such reproduced documentation. Information of third parties may be subject to additional restrictions. Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyers and others who are developing systems that incorporate TI products (collectively, "Designers") understand and agree that Designers remain responsible for using their independent analysis, evaluation and judgment in designing their applications and that Designers have full and exclusive responsibility to assure the safety of Designers' applications and compliance of their applications (and of all TI products used in or for Designers' applications) with all applicable regulations, laws and other applicable requirements. Designer represents that, with respect to their applications, Designer has all the necessary expertise to create and implement safeguards that (1) anticipate dangerous consequences of failures, (2) monitor failures and their consequences, and (3) lessen the likelihood of failures that might cause harm and take appropriate actions. Designer agrees that prior to using or distributing any applications that include TI products, Designer will thoroughly test such applications and the functionality of such TI products as used in such applications.

TI's provision of technical, application or other design advice, quality characterization, reliability data or other services or information, including, but not limited to, reference designs and materials relating to evaluation modules, (collectively, "TI Resources") are intended to assist designers who are developing applications that incorporate TI products; by downloading, accessing or using TI Resources in any way, Designer (individually or, if Designer is acting on behalf of a company, Designer's company) agrees to use any particular TI Resource solely for this purpose and subject to the terms of this Notice.

TI's provision of TI Resources does not expand or otherwise alter TI's applicable published warranties or warranty disclaimers for TI products, and no additional obligations or liabilities arise from TI providing such TI Resources. TI reserves the right to make corrections, enhancements, improvements and other changes to its TI Resources. TI has not conducted any testing other than that specifically described in the published documentation for a particular TI Resource.

Designer is authorized to use, copy and modify any individual TI Resource only in connection with the development of applications that include the TI product(s) identified in such TI Resource. NO OTHER LICENSE, EXPRESS OR IMPLIED, BY ESTOPPEL OR OTHERWISE TO ANY OTHER TI INTELLECTUAL PROPERTY RIGHT, AND NO LICENSE TO ANY TECHNOLOGY OR INTELLECTUAL PROPERTY RIGHT OF TI OR ANY THIRD PARTY IS GRANTED HEREIN, including but not limited to any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information regarding or referencing third-party products or services does not constitute a license to use such products or services, or a warranty or endorsement thereof. Use of TI Resources may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

TI RESOURCES ARE PROVIDED "AS IS" AND WITH ALL FAULTS. TI DISCLAIMS ALL OTHER WARRANTIES OR REPRESENTATIONS, EXPRESS OR IMPLIED, REGARDING RESOURCES OR USE THEREOF, INCLUDING BUT NOT LIMITED TO ACCURACY OR COMPLETENESS, TITLE, ANY EPIDEMIC FAILURE WARRANTY AND ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE, AND NON-INFRINGEMENT OF ANY THIRD PARTY INTELLECTUAL PROPERTY RIGHTS. TI SHALL NOT BE LIABLE FOR AND SHALL NOT DEFEND OR INDEMNIFY DESIGNER AGAINST ANY CLAIM, INCLUDING BUT NOT LIMITED TO ANY INFRINGEMENT CLAIM THAT RELATES TO OR IS BASED ON ANY COMBINATION OF PRODUCTS EVEN IF DESCRIBED IN TI RESOURCES OR OTHERWISE. IN NO EVENT SHALL TI BE LIABLE FOR ANY ACTUAL, DIRECT, SPECIAL, COLLATERAL, INDIRECT, PUNITIVE, INCIDENTAL, CONSEQUENTIAL OR EXEMPLARY DAMAGES IN CONNECTION WITH OR ARISING OUT OF TI RESOURCES OR USE THEREOF, AND REGARDLESS OF WHETHER TI HAS BEEN ADVISED OF THE POSSIBILITY OF SUCH DAMAGES.

Unless TI has explicitly designated an individual product as meeting the requirements of a particular industry standard (e.g., ISO/TS 16949 and ISO 26262), TI is not responsible for any failure to meet such industry standard requirements.

Where TI specifically promotes products as facilitating functional safety or as compliant with industry functional safety standards, such products are intended to help enable customers to design and create their own applications that meet applicable functional safety standards and requirements. Using products in an application does not by itself establish any safety features in the application. Designers must ensure compliance with safety-related requirements and standards applicable to their applications. Designer may not use any TI products in life-critical medical equipment unless authorized officers of the parties have executed a special contract specifically governing such use. Life-critical medical equipment is medical equipment where failure of such equipment would cause serious bodily injury or death (e.g., life support, pacemakers, defibrillators, heart pumps, neurostimulators, and implantables). Such equipment includes, without limitation, all medical devices identified by the U.S. Food and Drug Administration as Class III devices and equivalent classifications outside the U.S.

TI may expressly designate certain products as completing a particular qualification (e.g., Q100, Military Grade, or Enhanced Product). Designers agree that it has the necessary expertise to select the product with the appropriate qualification designation for their applications and that proper product selection is at Designers' own risk. Designers are solely responsible for compliance with all legal and regulatory requirements in connection with such selection.

Designer will fully indemnify TI and its representatives against any damages, costs, losses, and/or liabilities arising out of Designer's non-compliance with the terms and provisions of this Notice.